

# DDR3 SDRAM UDIMM

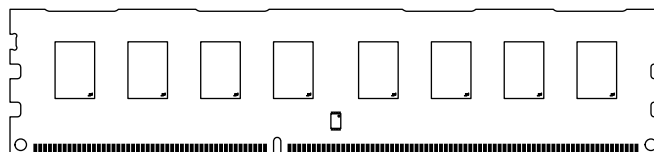
**MT16JTF25664AZ – 2GB**
**MT16JTF51264AZ – 4GB**

## Features

- DDR3 functionality and operations supported as per component data sheet
- 240-pin, unbuffered dual in-line memory module (UDIMM)
- Fast data transfer rates: PC3-12800, PC3-10600, PC3-8500, or PC3-6400
- 2GB (256 Meg x 64), 4GB (512 Meg x 64)
- $V_{DD} = V_{DDQ} = +1.5V \pm 0.75V$
- $V_{DDSPD} = +3.0V$  to  $+3.6V$
- Reset pin for improved system stability
- Nominal and dynamic on-die termination (ODT) for data, strobe, and mask signals
- Dual rank
- 8 internal device banks for concurrent operation
- Fixed burst length (BL) of 8 and burst chop (BC) of 4 via the mode register
- Adjustable data-output drive strength
- Serial presence-detect (SPD) EEPROM
- Gold edge contacts
- Halogen-free
- Addresses are mirrored for second rank
- Fly-by topology
- Terminated control, command, and address bus

**Figure 1: 240-Pin UDIMM (MO-269 R/C B)**

Module height: 30mm (1.18in)



## Options

- Operating temperature<sup>1</sup>
  - Commercial ( $0^{\circ}C \leq T_A \leq +70^{\circ}C$ )
  - Industrial ( $-40^{\circ}C \leq T_A \leq +85^{\circ}C$ )
- Package
  - 240-pin DIMM (halogen-free)
- Frequency/CAS latency
  - 1.25ns @ CL = 11 (DDR3-1600)
  - 1.5ns @ CL = 9 (DDR3-1333)
  - 1.87ns @ CL = 7 (DDR3-1066)

## Marking

None  
I  
Z  
-1G6  
-1G4  
-1G1

Note: 1. Contact Micron for industrial temperature module offerings.

**Table 1: Key Timing Parameters**

Speed Grade	Industry Nomenclature	Data Rate (MT/s)							$t_{RCD}$ (ns)	$t_{RP}$ (ns)	$t_{RC}$ (ns)
		CL = 11	CL = 10	CL = 9	CL = 8	CL = 7	CL = 6	CL = 5			
-1G6	PC3-12800	1600	1333	1333	1066	1066	800	667	13.125	13.125	48.125
-1G4	PC3-10600	–	1333	1333	1066	1066	800	667	13.125	13.125	49.125
-1G1	PC3-8500	–	–	–	1066	1066	800	667	13.125	13.125	50.625
-1G0	PC3-8500	–	–	–	1066	–	800	667	15	15	52.5
-80C	PC3-6400	–	–	–	–	–	800	800	12.5	12.5	50
-80B	PC3-6400	–	–	–	–	–	800	667	15	15	52.5



## 2GB, 4GB (x64, DR): 240-Pin DDR3 SDRAM UDIMM Features

**Table 2: Addressing**

Parameter	2GB	4GB
Refresh count	8K	8K
Row address	16K A[13:0]	32K A[14:0]
Device bank address	8 BA[2:0]	8 BA[2:0]
Device page size per bank	1KB	1KB
Device configuration	1Gb (128 Meg x 8)	2Gb (256 Meg x 8)
Column address	1K A[9:0]	1K A[9:0]
Module rank address	2 S#[1:0]	2 S#[1:0]

**Table 3: Part Numbers and Timing Parameters – 2GB Modules**

Base device: MT41J128M8,<sup>1</sup> 1Gb DDR3 SDRAM

Part Number <sup>2</sup>	Module Density	Configuration	Module Bandwidth	Memory Clock/ Data Rate	CL- <sup>t</sup> RCD- <sup>t</sup> RP (Clock Cycles)
MT16JTF25664A(I)Z-1G6__	2GB	256 Meg x 64	12.8 GB/s	1.25ns/1600 MT/s	11-11-11
MT16JTF25664A(I)Z-1G4__	2GB	256 Meg x 64	10.6 GB/s	1.5ns/1333 MT/s	9-9-9
MT16JTF25664A(I)Z-1G1__	2GB	256 Meg x 64	8.5 GB/s	1.87ns/1066 MT/s	7-7-7

**Table 4: Part Numbers and Timing Parameters – 4GB Modules**

Base device: MT41J256M8,<sup>1</sup> 2Gb DDR3 SDRAM

Part Number <sup>2</sup>	Module Density	Configuration	Module Bandwidth	Memory Clock/ Data Rate	CL- <sup>t</sup> RCD- <sup>t</sup> RP (Clock Cycles)
MT16JTF51264A(I)Z-1G6__	4GB	512 Meg x 64	12.8 GB/s	1.25ns/1600 MT/s	11-11-11
MT16JTF51264A(I)Z-1G4__	4GB	512 Meg x 64	10.6 GB/s	1.5ns/1333 MT/s	9-9-9
MT16JTF51264A(I)Z-1G1__	4GB	512 Meg x 64	8.5 GB/s	1.87ns/1066 MT/s	7-7-7

- Notes:
1. Data sheets for the base device parts can be found on Micron's Web site.
  2. All part numbers end with a two-place code (not shown), designating component and PCB revisions. Consult factory for current revision codes. Example: MT16JTF51264AZ-1G1B1.



## 2GB, 4GB (x64, DR): 240-Pin DDR3 SDRAM UDIMM Pin Assignments and Descriptions

### Pin Assignments and Descriptions

**Table 5: Pin Assignments**

240-Pin UDIMM Front								240-Pin UDIMM Back							
Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol
1	V <sub>REFDQ</sub>	31	DQ25	61	A2	91	DQ41	121	V <sub>SS</sub>	151	V <sub>SS</sub>	181	A1	211	V <sub>SS</sub>
2	V <sub>SS</sub>	32	V <sub>SS</sub>	62	V <sub>DD</sub>	92	V <sub>SS</sub>	122	DQ4	152	DM3	182	V <sub>DD</sub>	212	DM5
3	DQ0	33	DQS3#	63	CK1	93	DQS5#	123	DQ5	153	NC	183	V <sub>DD</sub>	213	NC
4	DQ1	34	DQS3	64	CK1#	94	DQS5	124	V <sub>SS</sub>	154	V <sub>SS</sub>	184	CK0	214	V <sub>SS</sub>
5	V <sub>SS</sub>	35	V <sub>SS</sub>	65	V <sub>DD</sub>	95	V <sub>SS</sub>	125	DM0	155	DQ30	185	CK0#	215	DQ46
6	DQS0#	36	DQ26	66	V <sub>DD</sub>	96	DQ42	126	NC	156	DQ31	186	V <sub>DD</sub>	216	DQ47
7	DQS0	37	DQ27	67	V <sub>REFCA</sub>	97	DQ43	127	V <sub>SS</sub>	157	V <sub>SS</sub>	187	NC	217	V <sub>SS</sub>
8	V <sub>SS</sub>	38	V <sub>SS</sub>	68	NC	98	V <sub>SS</sub>	128	DQ6	158	NC	188	A0	218	DQ52
9	DQ2	39	NC	69	V <sub>DD</sub>	99	DQ48	129	DQ7	159	NC	189	V <sub>DD</sub>	219	DQ53
10	DQ3	40	NC	70	A10	100	DQ49	130	V <sub>SS</sub>	160	V <sub>SS</sub>	190	BA1	220	V <sub>SS</sub>
11	V <sub>SS</sub>	41	V <sub>SS</sub>	71	BA0	101	V <sub>SS</sub>	131	DQ12	161	NC	191	V <sub>DD</sub>	221	DM6
12	DQ8	42	NC	72	V <sub>DD</sub>	102	DQS6#	132	DQ13	162	NC	192	RAS#	222	NC
13	DQ9	43	NC	73	WE#	103	DQS6	133	V <sub>SS</sub>	163	V <sub>SS</sub>	193	S0#	223	V <sub>SS</sub>
14	V <sub>SS</sub>	44	V <sub>SS</sub>	74	CAS#	104	V <sub>SS</sub>	134	DM1	164	NC	194	V <sub>DD</sub>	224	DQ54
15	DQS1#	45	NC	75	V <sub>DD</sub>	105	DQ50	135	NC	165	NC	195	ODT0	225	DQ55
16	DQS1	46	NC	76	S1#	106	DQ51	136	V <sub>SS</sub>	166	V <sub>SS</sub>	196	A13	226	V <sub>SS</sub>
17	V <sub>SS</sub>	47	V <sub>SS</sub>	77	ODT1	107	V <sub>SS</sub>	137	DQ14	167	NC	197	V <sub>DD</sub>	227	DQ60
18	DQ10	48	NC	78	V <sub>DD</sub>	108	DQ56	138	DQ15	168	RESET#	198	NC	228	DQ61
19	DQ11	49	NC	79	NC	109	DQ57	139	V <sub>SS</sub>	169	CKE1	199	V <sub>SS</sub>	229	V <sub>SS</sub>
20	V <sub>SS</sub>	50	CKE0	80	V <sub>SS</sub>	110	V <sub>SS</sub>	140	DQ20	170	V <sub>DD</sub>	200	DQ36	230	DM7
21	DQ16	51	V <sub>DD</sub>	81	DQ32	111	DQS7#	141	DQ21	171	NC	201	DQ37	231	NC
22	DQ17	52	BA2	82	DQ33	112	DQS7	142	V <sub>SS</sub>	172	NC/A14 <sup>1</sup>	202	V <sub>SS</sub>	232	V <sub>SS</sub>
23	V <sub>SS</sub>	53	NC	83	V <sub>SS</sub>	113	V <sub>SS</sub>	143	DM2	173	V <sub>DD</sub>	203	DM4	233	DQ62
24	DQS2#	54	V <sub>DD</sub>	84	DQS4#	114	DQ58	144	NC	174	A12	204	NC	234	DQ63
25	DQS2	55	A11	85	DQS4	115	DQ59	145	V <sub>SS</sub>	175	A9	205	V <sub>SS</sub>	235	V <sub>SS</sub>
26	V <sub>SS</sub>	56	A7	86	V <sub>SS</sub>	116	V <sub>SS</sub>	146	DQ22	176	V <sub>DD</sub>	206	DQ38	236	V <sub>DDSPD</sub>
27	DQ18	57	V <sub>DD</sub>	87	DQ34	117	SA0	147	DQ23	177	A8	207	DQ39	237	SA1
28	DQ19	58	A5	88	DQ35	118	SCL	148	V <sub>SS</sub>	178	A6	208	V <sub>SS</sub>	238	SDA
29	V <sub>SS</sub>	59	A4	89	V <sub>SS</sub>	119	SA2	149	DQ28	179	V <sub>DD</sub>	209	DQ44	239	V <sub>SS</sub>
30	DQ24	60	V <sub>DD</sub>	90	DQ40	120	V <sub>TT</sub>	150	DQ29	180	A3	210	DQ45	240	V <sub>TT</sub>

Note: 1. Pin 172 is NC for 2GB and A14 for 4GB.

**Table 6: Pin Descriptions**

Symbol	Type	Description
A[14:0]	Input	<b>Address inputs:</b> Provide the row address for ACTIVATE commands, and the column address and auto precharge bit (A10) for READ/WRITE commands, to select one location out of the memory array in the respective bank. A10 is sampled during a PRECHARGE command to determine whether the PRECHARGE applies to one bank (A10 LOW, bank selected by BA[2:0]) or all banks (A10 HIGH). If only one bank is to be precharged, the bank is selected by BA. A12 is also used for BC4/BL8 identification as "BL on-the-fly" during CAS commands. The address inputs also provide the op-code during the mode register command set. A[13:0] address the 1Gb DDR3 devices. A[14:0] address the 2Gb DDR3 devices.
BA[2:0]	Input	<b>Bank address inputs:</b> BA[2:0] define the device bank to which an ACTIVATE, READ, WRITE, or PRECHARGE command is being applied. BA[2:0] define which mode register (MR0, MR1, MR2, and MR3) is loaded during the LOAD MODE command.
CK[1:0] CK#[1:0]	Input	<b>Clock:</b> CK and CK# are differential clock inputs. All control, command, and address input signals are sampled on the crossing of the positive edge of CK and the negative edge of CK#.
CKE[1:0]	Input	<b>Clock enable:</b> CKE enables (registered HIGH) and disables (registered LOW) internal circuitry and clocks on the DRAM.
DM[7:0]	Input	<b>Input data mask:</b> DM is an input mask signal for write data. Input data is masked when DM is sampled HIGH, along with the input data, during a write access. DM is sampled on both edges of the DQS. Although the DM pins are input-only, the DM loading is designed to match that of the DQ and DQS pins.
ODT[1:0]	Input	<b>On-die termination:</b> ODT enables (registered HIGH) and disables (registered LOW) termination resistance internal to the DRAM. When enabled in normal operation, ODT is only applied to the following pins: DQ, DQS, DQS#, and DM. The ODT input will be ignored if disabled via the LOAD MODE command.
RAS#, CAS#, WE#	Input	<b>Command inputs:</b> RAS#, CAS#, and WE# (along with S#) define the command being entered.
RESET#	Input (LVCMOS)	<b>Reset:</b> RESET# is an active LOW CMOS input referenced to V <sub>SS</sub> . The RESET# input receiver is a CMOS input defined as a rail-to-rail signal with DC HIGH $\geq 0.8 \times V_{DD}$ and DC LOW $\leq 0.2 \times V_{DD}$ .
S#[1:0]	Input	<b>Chip select:</b> S# enables (registered LOW) and disables (registered HIGH) the command decoder.
SA[2:0]	Input	<b>Serial address inputs:</b> These pins are used to configure the temperature sensor/SPD EEPROM address range on the I <sup>2</sup> C bus.
SCL	Input	<b>Serial clock for temperature sensor/SPD EEPROM:</b> SCL is used to synchronize the communication to and from the temperature sensor/SPD EEPROM.
DQ[63:0]	I/O	<b>Data input/output:</b> Bidirectional data bus.
DQS[7:0] DQS#[7:0]	I/O	<b>Data strobe:</b> DQS and DQS# are differential data strobes. Output with read data. Edge-aligned with read data. Input with write data. Center-aligned with write data.
SDA	I/O	<b>Serial data:</b> SDA is a bidirectional pin used to transfer addresses and data into and out of the temperature sensor/SPD EEPROM on the module on the I <sup>2</sup> C bus.
V <sub>DD</sub>	Supply	<b>Power supply:</b> 1.5V $\pm 0.075V$ . The component V <sub>DD</sub> and V <sub>DDQ</sub> are connected to the module V <sub>DD</sub> .
V <sub>DDSPD</sub>	Supply	<b>Temperature sensor/SPD EEPROM power supply:</b> +3.0V to +3.6V.
V <sub>REFCA</sub>	Supply	<b>Reference voltage:</b> Control, command, and address (V <sub>DD</sub> /2).



## 2GB, 4GB (x64, DR): 240-Pin DDR3 SDRAM UDIMM Pin Assignments and Descriptions

**Table 6: Pin Descriptions (Continued)**

Symbol	Type	Description
$V_{REFDQ}$	Supply	<b>Reference voltage:</b> DQ, DM ( $V_{DD}/2$ ).
$V_{SS}$	Supply	Ground.
$V_{TT}$	Supply	<b>Termination voltage:</b> Used for control, command, and address ( $V_{DD}/2$ ).
NC	–	<b>No connect:</b> These pins are not connected on the module.

## DQ Map

**Table 7: Component-to-Module DQ Map**

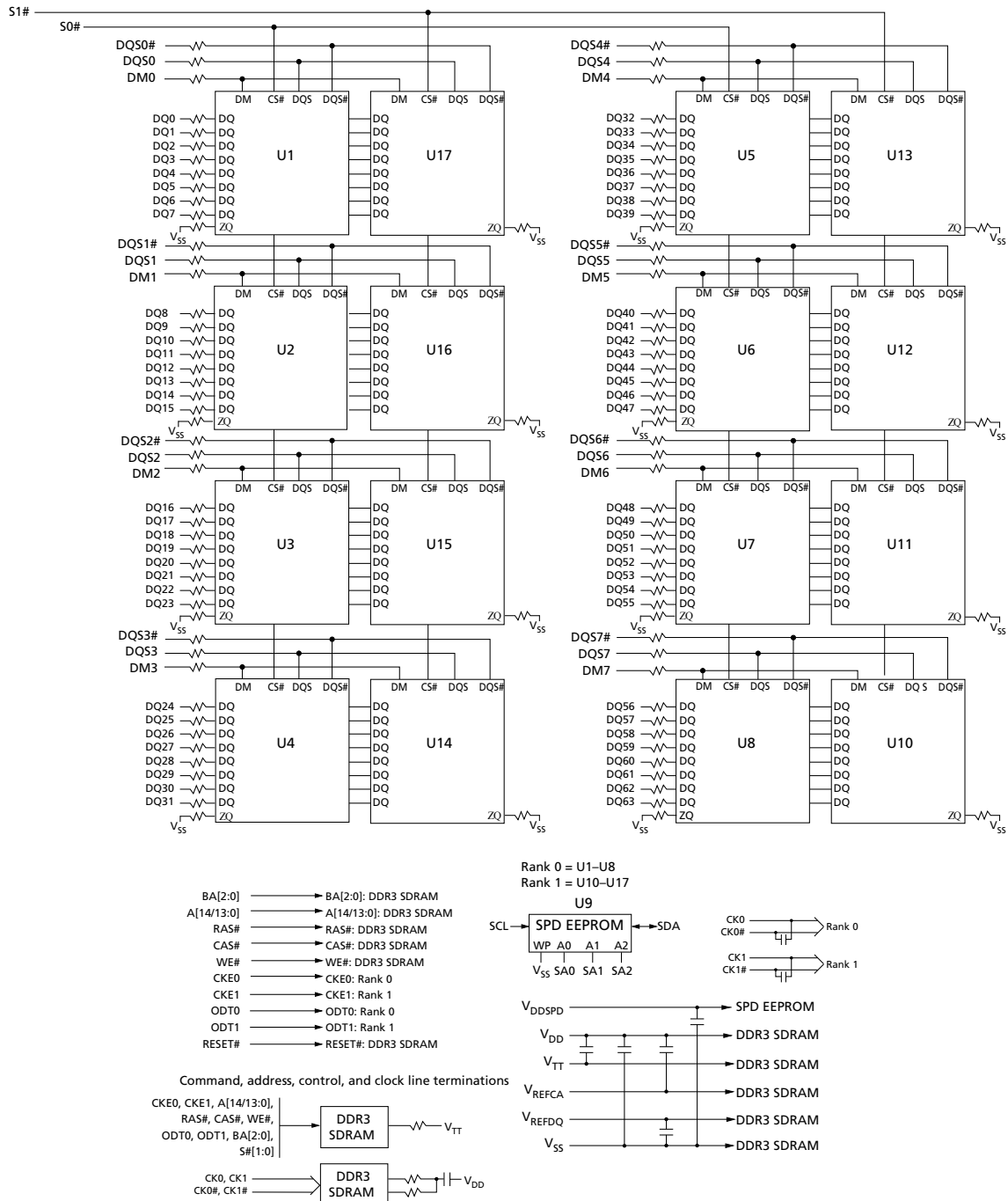
Component Reference Number	Component DQ	Module DQ	Module Pin Number	Component Reference Number	Component DQ	Module DQ	Module Pin Number
U1	0	2	9	U2	0	10	18
	1	5	123		1	13	132
	2	7	129		2	15	138
	3	1	4		3	9	13
	4	6	128		4	14	137
	5	4	122		5	12	131
	6	3	10		6	11	19
	7	0	3		7	8	12
U3	0	18	27	U4	0	26	36
	1	21	141		1	29	150
	2	23	147		2	31	156
	3	17	22		3	25	31
	4	22	146		4	30	155
	5	20	140		5	28	149
	6	19	28		6	27	37
	7	16	21		7	24	30
U5	0	34	87	U6	0	42	96
	1	37	201		1	45	210
	2	39	207		2	47	216
	3	33	82		3	41	91
	4	38	206		4	46	215
	5	36	200		5	44	209
	6	35	88		6	43	97
	7	32	81		7	40	90
U7	0	50	105	U8	0	58	114
	1	53	219		1	61	228
	2	55	225		2	63	234
	3	49	100		3	57	109
	4	54	224		4	62	233
	5	52	218		5	60	227
	6	51	106		6	59	115
	7	48	99		7	56	108

**Table 7: Component-to-Module DQ Map (Continued)**

Component Reference Number	Component DQ	Module DQ	Module Pin Number	Component Reference Number	Component DQ	Module DQ	Module Pin Number
U10	0	61	228	U11	0	53	219
	1	58	114		1	50	105
	2	57	109		2	49	100
	3	63	234		3	55	225
	4	56	108		4	48	99
	5	59	115		5	51	106
	6	60	227		6	52	218
	7	62	233		7	54	224
U12	0	45	210	U13	0	37	201
	1	42	96		1	34	87
	2	41	91		2	33	82
	3	47	216		3	39	207
	4	40	90		4	32	81
	5	43	97		5	35	88
	6	44	209		6	36	200
	7	46	215		7	38	206
U14	0	29	150	U15	0	21	141
	1	26	36		1	18	27
	2	25	31		2	17	22
	3	31	156		3	23	147
	4	24	30		4	16	21
	5	27	37		5	19	28
	6	28	149		6	20	140
	7	30	155		7	22	146
U16	0	13	132	U17	0	5	123
	1	10	18		1	2	9
	2	9	13		2	1	4
	3	15	138		3	7	129
	4	8	12		4	0	3
	5	11	19		5	3	10
	6	12	131		6	4	122
	7	14	137		7	6	128

## Functional Block Diagram

Figure 2: Functional Block Diagram



Note: 1. The ZQ ball on each DDR3 component is connected to an external 240Ω resistor that is tied to ground. Used for the calibration of the component's on-die termination and output driver.



## General Description

DDR3 SDRAM modules are high-speed, CMOS dynamic random access memory modules that use internally configured 8-bank DDR3 SDRAM devices. DDR3 SDRAM modules use DDR architecture to achieve high-speed operation. DDR3 architecture is essentially an  $8n$ -prefetch architecture with an interface designed to transfer two data words per clock cycle at the I/O pins. A single read or write access for the DDR3 SDRAM module effectively consists of a single  $8n$ -bit-wide, one-clock-cycle data transfer at the internal DRAM core and eight corresponding  $n$ -bit-wide, one-half-clock-cycle data transfers at the I/O pins.

DDR3 modules use two sets of differential signals: DQS, DQS# to capture data and CK and CK# to capture commands, addresses, and control signals. Differential clocks and data strobes ensure exceptional noise immunity for these signals and provide precise crossing points to capture input signals.

## Fly-By Topology

DDR3 modules use faster clock speeds than earlier DDR technologies, making signal quality more important than ever. For improved signal quality, the clock, control, command, and address buses have been routed in a fly-by topology, where each clock, control, command, and address pin on each DRAM is connected to a single trace and terminated (rather than a tree structure, where the termination is off the module near the connector). Inherent to fly-by topology, the timing skew between the clock and DQS signals can be easily accounted for by using the write-leveling feature of DDR3.

## Serial Presence-Detect EEPROM Operation

DDR3 SDRAM modules incorporate serial presence-detect. The SPD data is stored in a 256-byte EEPROM. The first 128 bytes are programmed by Micron to comply with JEDEC standard JC-45, "Appendix X: Serial Presence Detect (SPD) for DDR3 SDRAM Modules." These bytes identify module-specific timing parameters, configuration information, and physical attributes. User-specific information can be written into the remaining 128 bytes of storage. READ/WRITE operations between the system (master) and the EEPROM (slave) device occur via an I<sup>2</sup>C bus. Write protect (WP) is connected to Vss, permanently disabling hardware write protect. For further information please refer to Micron technical note TN-04-42, "Memory Module Serial Presence-Detect."

## Electrical Specifications

Stresses greater than those listed may cause permanent damage to the module. This is a stress rating only, and functional operation of the module at these or any other conditions outside those indicated in each device's data sheet is not implied. Exposure to absolute maximum rating conditions for extended periods may adversely affect reliability.

**Table 8: Absolute Maximum Ratings**

Symbol	Parameter	Min	Max	Units
$V_{DD}$	$V_{DD}$ supply voltage relative to $V_{SS}$	-0.4	+1.975	V
$V_{IN}, V_{OUT}$	Voltage on any pin relative to $V_{SS}$	-0.4	+1.975	V

**Table 9: Operating Conditions**

Symbol	Parameter	Min	Nom	Max	Units	Notes
$V_{DD}$	$V_{DD}$ supply voltage	1.425	1.5	1.575	V	
$I_{VTT}$	Termination reference current from $V_{TT}$	-600	-	+600	mA	
$V_{TT}$	Termination reference voltage – command address bus	$0.483 \times V_{DD}$	$0.5 \times V_{DD}$	$0.517 \times V_{DD}$	V	1
$I_I$	Input leakage current; Any input $0V \leq V_{IN} \leq V_{DD}$ ; $V_{REF}$ input $0V \leq V_{IN} \leq 0.95V$ (All other pins not under test = 0V)	Address inputs RAS#, CAS#, WE#, BA	-32	0	+32	$\mu A$
		S#, CKE, ODT, CK, CK#	-16	0	+16	
		DM	-4	0	+4	
$I_{OZ}$	Output leakage current; $0V \leq V_{OUT} \leq V_{DDQ}$ ; DQs and ODT are disabled	DQ, DQS, DQS#	-10	0	+10	$\mu A$
$I_{VREF}$	$V_{REF}$ leakage current; $V_{REF}$ = valid $V_{REF}$ level		-16	0	+16	$\mu A$
$T_A$	Module ambient operating temperature	Commercial	0	-	+70	$^{\circ}C$
		Industrial	-40	-	+85	$^{\circ}C$
$T_C$	DDR3 SDRAM component case operating temperature	Commercial	0	-	+85	$^{\circ}C$
		Industrial	-40	-	+95	$^{\circ}C$

- Notes:
1.  $V_{TT}$  termination voltage in excess of the stated limit will adversely affect the command and address signals' voltage margin and will reduce timing margins.
  2.  $T_A$  and  $T_C$  are simultaneous requirements.
  3. For further information, refer to technical note TN-00-08: "Thermal Applications," available on Micron's Web site.
  4. The refresh rate is required to double when  $85^{\circ}C < T_C \leq 95^{\circ}C$ .



### DRAM Operating Conditions

Recommended AC operating conditions are given in the DDR3 component data sheets. Component specifications are available on Micron's Web site. Module speed grades correlate with component speed grades, as shown below.

**Table 10: Module and Component Speed Grades**

DDR3 components may exceed the listed module speed grades; module may not be available in all listed speed grades

Module Speed Grade	Component Speed Grade
-1G6	-125
-1G4	-15E
-1G1	-187E
-1G0	-187
-80C	-25E
-80B	-25

### Design Considerations

#### Simulations

Micron memory modules are designed to optimize signal integrity through carefully designed terminations, controlled board impedances, routing topologies, trace length matching, and decoupling. However, good signal integrity starts at the system level. Micron encourages designers to simulate the signal characteristics of the system's memory bus to ensure adequate signal integrity of the entire memory system.

#### Power

Operating voltages are specified at the DRAM, not at the edge connector of the module. Designers must account for any system voltage drops at anticipated power levels to ensure the required supply voltage is maintained.



## 2GB, 4GB (x64, DR): 240-Pin DDR3 SDRAM UDIMM Electrical Specifications

### I<sub>DD</sub> Specifications

**Table 11: DDR3 I<sub>DD</sub> Specifications and Conditions – 2GB**

Values are for the MT41J128M8 DDR3 SDRAM only and are computed from values specified in the 1Gb (128 Meg x 8) component data sheet

Parameter	Symbol	1600	1333	1066	Units
Operating current 0: One bank ACTIVATE-to-PRECHARGE	I <sub>DD0</sub> <sup>1</sup>	1056	976	896	mA
Operating current 1: One bank ACTIVATE-to-READ-to-PRECHARGE	I <sub>DD1</sub> <sup>1</sup>	1216	1136	1056	mA
Precharge power-down current: Slow exit	I <sub>DD2P0</sub> <sup>2</sup>	192	192	192	mA
Precharge power-down current: Fast exit	I <sub>DD2P1</sub> <sup>2</sup>	720	640	560	mA
Precharge quiet standby current	I <sub>DD2Q</sub> <sup>2</sup>	1072	960	848	mA
Precharge standby current	I <sub>DD2N</sub> <sup>2</sup>	1120	1040	880	mA
Precharge standby ODT current	I <sub>DD2NT</sub> <sup>2</sup>	856	776	696	mA
Active power-down current	I <sub>DD3P</sub> <sup>2</sup>	720	640	560	mA
Active standby current	I <sub>DD3N</sub> <sup>2</sup>	1072	992	912	mA
Burst read operating current	I <sub>DD4R</sub> <sup>1</sup>	2096	1696	1376	mA
Burst write operating current	I <sub>DD4W</sub> <sup>1</sup>	2096	1856	1616	mA
Refresh current	I <sub>DD5B</sub> <sup>2</sup>	4160	3840	3520	mA
Self refresh temperature current: MAX T <sub>C</sub> = 85°C	I <sub>DD6</sub> <sup>2</sup>	96	96	96	mA
Self refresh temperature current (SRT-enabled): MAX T <sub>C</sub> = 95°C	I <sub>DD6ET</sub> <sup>2</sup>	144	144	144	mA
All banks interleaved read current	I <sub>DD7</sub> <sup>1</sup>	4896	4016	3216	mA
Reset current	I <sub>DD8</sub> <sup>2</sup>	224	224	224	mA

- Notes: 1. One module rank in the active I<sub>DD</sub>; the other rank in I<sub>DD2P50</sub> (slow exit).  
2. All ranks in this I<sub>DD</sub> condition.

**Table 12: DDR3 I<sub>DD</sub> Specifications and Conditions – 4GB**

Values are for the MT41J256M8 DDR3 SDRAM only and are computed from values specified in the 2Gb (256 Meg x 8) component data sheet

Parameter	Symbol	1600	1333	1066	Units
Operating current 0: One bank ACTIVATE-to-PRECHARGE	I <sub>DD0</sub> <sup>1</sup>	TBD	816	736	mA
Operating current 1: One bank ACTIVATE-to-READ-to-PRECHARGE	I <sub>DD1</sub> <sup>1</sup>	TBD	1016	896	mA
Precharge power-down current: Slow exit	I <sub>DD2P0</sub> <sup>2</sup>	TBD	192	192	mA
Precharge power-down current: Fast exit	I <sub>DD2P1</sub> <sup>2</sup>	TBD	560	480	mA
Precharge quiet standby current	I <sub>DD2Q</sub> <sup>2</sup>	TBD	1040	880	mA
Precharge standby current	I <sub>DD2N</sub> <sup>2</sup>	TBD	1040	880	mA
Precharge standby ODT current	I <sub>DD2NT</sub> <sup>2</sup>	TBD	776	696	mA
Active power-down current	I <sub>DD3P</sub> <sup>2</sup>	TBD	720	640	mA
Active standby current	I <sub>DD3N</sub> <sup>2</sup>	TBD	1200	960	mA
Burst read operating current	I <sub>DD4R</sub> <sup>1</sup>	TBD	1696	1376	mA
Burst write operating current	I <sub>DD4W</sub> <sup>1</sup>	TBD	2016	1696	mA
Refresh current	I <sub>DD5B</sub> <sup>2</sup>	TBD	4080	3920	mA
Self refresh temperature current: MAX T <sub>C</sub> = 85°C	I <sub>DD6</sub> <sup>2</sup>	TBD	144	144	mA
Self refresh temperature current (SRT-enabled): MAX T <sub>C</sub> = 95°C	I <sub>DD6ET</sub> <sup>2</sup>	TBD	192	192	mA
All banks interleaved read current	I <sub>DD7</sub> <sup>1</sup>	TBD	3016	2656	mA
Reset current	I <sub>DD8</sub> <sup>2</sup>	TBD	224	224	mA

Notes: 1. One module rank in the active I<sub>DD</sub>; the other rank in I<sub>DD2P0</sub> (slow exit).  
2. All ranks in this I<sub>DD</sub> condition.

## Serial Presence-Detect EEPROM

**Table 13: Serial Presence-Detect EEPROM DC Operating Conditions**

All voltages referenced to  $V_{DDSPD}$

Parameter/Condition	Symbol	Min	Max	Units
Supply voltage	$V_{DDSPD}$	3.0	3.6	V
Input low voltage: Logic 0; All inputs	$V_{IL}$	-0.6	$V_{DDSPD} + 0.3$	V
Input high voltage: Logic 1; All inputs	$V_{IH}$	$V_{DDSPD} + 0.7$	$V_{DDSPD} + 1.0$	V
Output low voltage: $I_{OUT} = 3\text{mA}$	$V_{OL}$	–	0.4	V
Input leakage current: $V_{IN} = \text{GND to } V_{DD}$	$I_{LI}$	0.1	2.0	$\mu\text{A}$
Output leakage current: $V_{OUT} = \text{GND to } V_{DD}$	$I_{LO}$	0.05	2.0	$\mu\text{A}$

**Table 14: Serial Presence-Detect EEPROM AC Operating Conditions**

Parameter/Condition	Symbol	Min	Max	Units	Notes
Clock frequency	$t^{\text{SCL}}$	10	400	kHz	
Clock pulse width high time	$t^{\text{HIGH}}$	0.6	–	$\mu\text{s}$	
Clock pulse width low time	$t^{\text{LOW}}$	1.3	–	$\mu\text{s}$	
SDA rise time	$t^{\text{R}}$	–	300	$\mu\text{s}$	1
SDA fall time	$t^{\text{F}}$	20	300	ns	1
Data-in setup time	$t^{\text{SU:DAT}}$	100	–	ns	
Data-in hold time	$t^{\text{HD:DI}}$	0	–	$\mu\text{s}$	
Data-out hold time	$t^{\text{HD:DAT}}$	200	900	ns	
Data out access time from SCL low	$t^{\text{AA:DAT}}$	0.2	0.9	$\mu\text{s}$	2
Start condition setup time	$t^{\text{SU:STA}}$	0.6	–	$\mu\text{s}$	3
Start condition hold time	$t^{\text{HD:STA}}$	0.6	–	$\mu\text{s}$	
Stop condition setup time	$t^{\text{SU:STO}}$	0.6	–	$\mu\text{s}$	
Time the bus must be free before a new transition can start	$t^{\text{BUF}}$	1.3	–	$\mu\text{s}$	
WRITE time	$t^{\text{W}}$	–	10	ms	

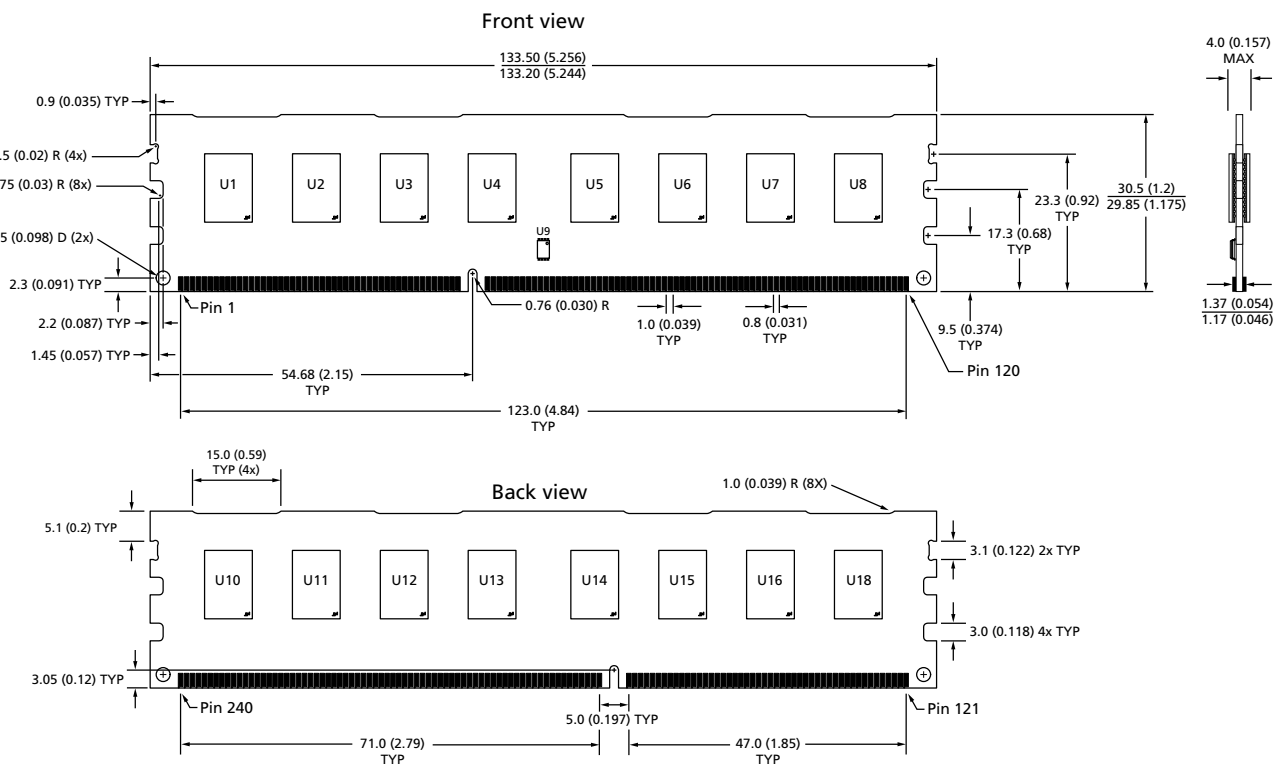
- Notes:
1. Guaranteed by design and characterization, not necessarily tested.
  2. To avoid spurious start and stop conditions, a minimum delay is placed between the falling edge of SCL and the falling or rising edge of SDA.
  3. For a restart condition, or following a WRITE cycle.

## Serial Presence-Detect Data

For the latest serial presence-detect data, refer to Micron's SPD page:  
[www.micron.com/SPD](http://www.micron.com/SPD).

## Module Dimensions

**Figure 3: 240-Pin DDR3 UDIMM**



- Notes:
1. All dimensions are in millimeters (inches); MAX/MIN or typical (TYP) where noted.
  2. The dimensional diagram is for reference only. Refer to the JEDEC MO document for additional design dimensions.

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This data sheet contains minimum and maximum limits specified over the power supply and temperature range set forth herein. Although considered final, these specifications are subject to change, as further product development and data characterization sometimes occur.